

Notice of References Cited

Application/Control No.

10/524,227

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

LINH T. NGUYEN

Art Unit

2627

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,363,212	03-2002	Fujinami et al.	386/104
*	B	US-5,802,245	09-1998	Kunihiro, Hideto	386/98
	C	US-			
	D	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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